

Notice of References Cited	Application/Control No. 10/757,202	Applicant(s)/Patent Under Reexamination TSENG ET AL.	
	Examiner DuyVu n. Deo	Art Unit 1765	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,638,866	10-2003	Cheng et al.	438/692
	B	US-2003/0166381	09-2003	Lee et al.	451/41
	C	US-6,429,134	08-2002	Kubota et al.	438/692
	D	US-6,593,240	07-2003	Page, Joseph E.	438/692
	E	US-6,326,309	12-2001	Hatanaka et al.	438/693
	F	US-6,824,452	11-2004	Hung et al.	451/57
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
	O					
	P					
	Q					
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	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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